

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. <b>00169.101769</b>		APPLICATION NO. <b>10/807,101</b>		
			<b>APPLICANT</b> <b>IAN RICHARD BEAUMONT</b>				
			FILING DATE <b>March 24, 2004</b>		GROUP <b>2628</b>		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/AY/		<b>4,737,980</b>	<b>04/12/88</b>	<b>Curtin et al.</b>	<b>379</b>	<b>97</b>	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/AY/		<b>5-135025</b>	<b>06/01/93</b>	<b>Japan</b>	<del>      </del>	<del>      </del>	<b>Abstract</b>
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	/Andrew Yang/		DATE CONSIDERED	06/15/2007			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/AY/		<b>6,320,667 B1</b>	<b>11/20/01</b>	<b>Mitsuhashi</b>	<b>358</b>	<b>1.1</b>	
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Form #62

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/AY/		<b>6,320,667 B1</b>	<b>11/20/01</b>	<b>Mitsuhashi</b>	<b>358</b>	<b>1.1</b>	
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/AY/	JP	<b>2000-112693</b>	<b>04/21/00</b>	<b>Japan</b>			<b>Abstract</b>
/AY/	JP	<b>5-135025</b>	<b>06/01/93</b>	<b>Japan</b>			<b>Abstract</b>
<b>OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
/AY/		<b>Copy of Japanese Office Action dated November 27, 2006, in counterpart Application No. 2004-096967.</b>					
/AY/		<b>Copy of Japanese Office Action dated February 26, 2007, in counterpart Application No. 2004-096967.</b>					
EXAMINER	<b>/Andrew Yang/</b>		DATE CONSIDERED		<b>06/15/2007</b>		

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